150

Docket No. 241677US2/ims

# IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Kenji YOSHIDA, et al.

SERIAL NO: 10/642,222 GAU: 2812

August 18, 2003 EXAMINER:

METHOD OF ACCELERATING TEST OF SEMICONDUCTOR DEVICE

FORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS
PALES NORIA, VIRGINIA 22313

SIR:

Applicant(s) wish to disclose the following information.

#### REFERENCES

- The applicant(s) wish to make of record the references cited in the attached Japanese Office Action and listed on the attached form PTO-1449. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.
- ☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

## **RELATED CASES**

- Attached is a list of applicant's pending application(s), published application(s) or issued patent(s) which may be related to the present application. In accordance with the waiver of 37 CFR 1.98 dated September 21, 2004, copies of the cited pending applications are not provided. Cited published and/or issued patents, if any, are listed on the attached PTO form 1449.
- A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

#### **CERTIFICATION**

- Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
  - No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

## **DEPOSIT ACCOUNT**

Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number <u>15-0030</u>. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND, MAIER & NEUSTADT, P.C.

Marvin J. Spivak

Registration No. 24,913

Joseph Scafetta, Jr.

Registration No. 26,803

Customer Number

22850

Tel. (703) 413-3000 Fax. (703) 413-2220 (OSMMN 05/03)

Form PTO 1449	U.S. DEPARTMENT OF COMMERCE TRADE AT AND TRADEMARK OFFICE			ATTY DOCKET NO.			SERIAL NO.			
(Modified)		RADA AT AND TRA	DEMARK OFFICE	241677US2			10/642,222			
				APPLICANT						
LIST OF	REFER	RENCES CITED BY A	PPLICANT	Kenji YOSHID	A et al					
				FILING DATE			GROUP			
				August 18, 2003			2812			
				U.S. PATENT DOC	JMENTS	<del></del>				
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME CLASS			SUB FILING DATE CLASS IF APPROPRIATE			
	AA									
	AB									
	AC	.,								
	AD		<u> </u>							
	AE		<del>- </del>		· · · · · · · · · · · · · · · · · · ·			- 12		
	AF		<del> </del>	1						
	AG									
	AH			1						
	AI	-								
	AJ									
	AK									
	AL									
	AM									
	AN									
			FC	REIGN PATENT DO	CUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY			TRANSLATION YES NO			
<b>—</b>	AO	10-12687	01/16/1998	JAPAN					×	
	AP	3-254126	11/13/1991	JAPAN					X	
	AQ					. ,,			· · · · · · · · · · · · · · · · · · ·	
	AR		<del> </del>						<del></del>	
	AS	-								
	AT						<u> </u>			
	AU									
	AV									
		OTHER R	EFERENCES	Including Author,	litle, Date, Pertine	ent Pages, e	tc.)			
	AW									
	AX									
	AY									
, ,,	AZ		A* .	Additional References sheet(s) attached						
Examiner				<del>.</del>		Date Cor	Date Considered			
*Examiner: In	itial if r	eference is considered	, whether or no	t citation is in confor	mance with MPEP	609; Draw li	ne through	citation if r	not in	
contormance	and no	ot considered. Include	copy of this form	a with next communi	cation to applicant.					